

# zkratovna

HIGH POWER LABORATORY

13 - 167

ZKUŠEBNICTVÍ, a.s.

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## zkratovna

Zkušebnictví, a. s.

Podnikatelská 547, 190 11 Praha 9, Běchovice, Czech Republic

## TEST REPORT No. 13 - 167

**Test object** 

Type

Reference No.

Serial No.

: HV current-limiting fuse-link

: NH 4000V d.c. aR

004735605

Ratings

Rated voltage Rated current Rated frequency

: 4000 V d.c. : 250 A : 50 Hz

Manufacturer

: ETI ELEKTROELEMENT d.d. Obrezija 5, 1411 Izlake, Slovenia

Test performed

Breaking tests (Test 11 and Test 12) Customer's request based on IEC 60269-4:2009, cl. 8.5

Customer

: ETI ELEKTROELEMENT d.d. Obrezija 5, 1411 Izlake, Slovenia

Date of test

: 05. 09. 2013

THIS TEST REPORT IS CONFIDENTIAL AND SHALL NOT BE PASSED OVER OR TRANSFERRED TO ANY THIRD PARTY WITHOUT WRITTEN APPROVAL OF THE CUSTOMER.

WITHOUT THE WRITTEN APPROVAL OF THE TESTING LABORATORY ZKRATOVNA SHALL NOT BE REPRODUCED EXCEPT IN FULL.

Number of issued copies: 1

Praha 9, Běchovice on 14 10.2013

Copy No.: 1

Tested by:

Richard Abrahamčík

Approved by:

Robert Jech Head of the Laboratory



### zkratovna Zkušebnictví, a.s.

Test Report No.: 13 - 167

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#### Description of the test object

DC current limiting fuse-links for the protection of semiconductor devices.

Type

: NH 4000V d.c. aR

Manufacturer

: ETI ELEKTROELEMENT d.d., Izlake, Slovenia

Year of manufacture : 2013
Rated voltage : 4000 V d.c.

Rated current

250 A

Rated current Characteristic

aR

Length

: 418 mm

#### **Test specification**

The tests were carried out according to the customer's instructions. The test procedures, parameters and test assessment criteria are based on IEC 60269-4:2009, cl. 8.5.

#### **Test parameters**

**Test 11** 

Test voltage : 4,2 kV
Prospective current I<sub>1</sub> : 30 kA
Time constant : 10 ÷ 15 ms

<u>Test 12</u>

Test voltage 4,2 kV
Prospective current I<sub>2a</sub> : 1,97 kA
Time constant : 5 ms

: 5 ms

#### Summary

All the tests as required by the test specification were performed.

More details of the tests performed are given in the enclosed tables and oscillograms.